

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10560618	CHIBA ET AL.
	Examiner	Art Unit
	Ton, Anabel M	2875

SEARCHED

Class	Subclass	Date	Examiner
362	728-736,806,807,720-723	09/29/07	AT
362/800,249			

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner